



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

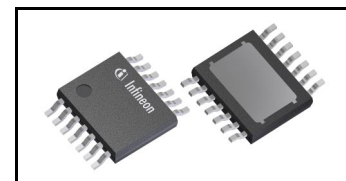


TLE94003EP



Features

- Three half bridge power outputs
- Very low power consumption in sleep mode
- 3.3V / 5V compatible inputs with hysteresis
- All outputs with overload and short circuit protection
- Direct interface for control and diagnosis
- Overtemperature protection
- Over- and Undervoltage lockout
- Cross-current protection



Potential applications

- HVAC Flap DC motors
- Monostable and bistable relays
- Side mirror x-y adjustment

Product validation

Qualified for Automotive Applications. Product Validation according to AEC-Q100

Description

The TLE94003EP is a protected triple half-bridge driver designed especially for automotive motion control applications such as side mirror x-y adjustment. It is part of a larger family offering half-bridge drivers from three outputs to twelve outputs with direct interface or SPI interface.

The half bridge drivers are designed to drive DC motor loads in sequential or parallel operation. Operation modes forward (cw), reverse (ccw), brake and high impedance are controlled from a direct interface. It offers diagnosis features such as short circuit, power supply failure and overtemperature detection. In combination with its low quiescent current, this device is attractive among others for automotive applications. The small fine pitch exposed pad package, PG-TSDSO-14, provides good thermal performance and reduces PCB-board space and costs.

Type	Package	Marking
TLE94003EP	PG-TSDSO-14	TLE94003

Table 1 Product Summary

Operating Voltage	V_S	5.5 ... 20 V
Logic Supply Voltage	V_{DD}	3.0 ... 5.5 V
Maximum Supply Voltage for Load Dump Protection	$V_{S(LD)}$	40 V
Minimum Overcurrent Threshold	I_{SD}	0.9 A
Maximum On-State Path Resistance at $T_j = 150^\circ\text{C}$	$R_{DSON(total)}_{HSx+LSy}$	1.8 + 1.8 Ω
Typical Quiescent Current at $T_j = 85^\circ\text{C}$	I_{SQ}	0.1 μA

Table of Contents

1	Pin Configuration	4
1.1	Pin Assignment	4
1.2	Pin Definitions and Functions	4
2	Block Diagram	6
2.1	Voltage and current definition	7
3	General Product Characteristics	8
3.1	Absolute Maximum Ratings	8
3.2	Functional Range	10
3.3	Thermal Resistance	11
3.4	Electrical Characteristics	12
4	Characterization results	15
5	General Description	20
5.1	Power Supply	20
5.2	Operation modes	20
5.2.1	Normal mode	20
5.2.2	Sleep mode	20
5.3	Reset Behaviour	20
5.4	Reverse Polarity Protection	20
6	Half-Bridge Outputs	22
6.1	Output Stages	22
6.2	Diagnosis Monitoring	25
6.3	Protection	25
6.3.1	Short Circuit of Output to Supply or Ground	25
6.3.2	Cross-current protection	26
6.3.3	Temperature monitoring and shutdown	28
6.3.4	VS Undervoltage Behaviour	30
6.3.5	VS Overvoltage Behaviour	31
6.3.6	V _{DD} Undervoltage	31
7	Application Information	32
7.1	Application Diagram	32
7.2	Thermal application information	35
8	Package Outlines	36
9	Revision History	37

Pin Configuration

1 Pin Configuration

1.1 Pin Assignment

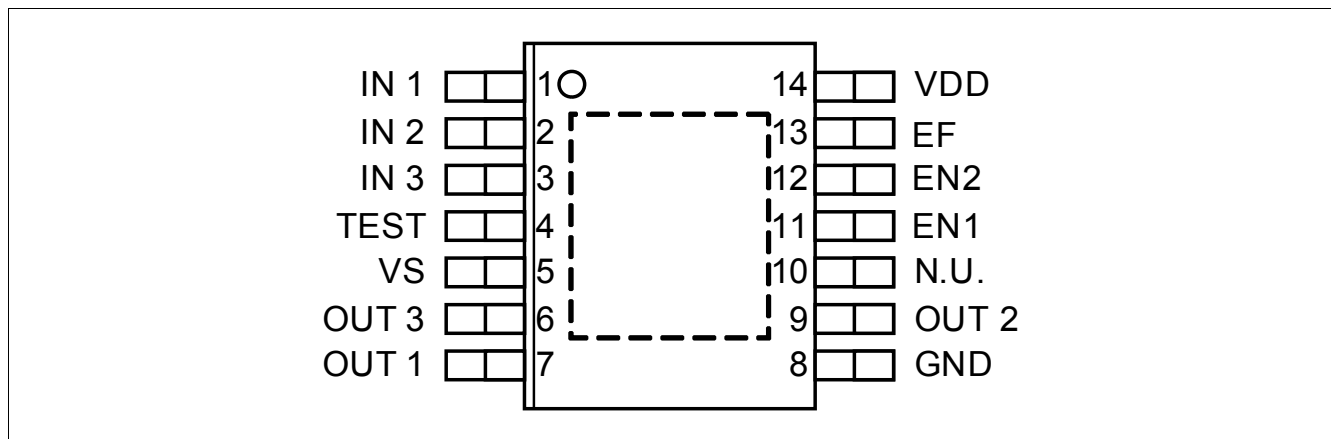


Figure 1 Pin Configuration TLE94003EP with direct interface

1.2 Pin Definitions and Functions

Pin	Symbol	Function
1	IN1	Direct input control for power half-bridge 1
2	IN2	Direct input control for power half-bridge 2
3	IN3	Direct input control for power half-bridge 3
4	TEST	Test input. This pin can be left open or be terminated to ground
5	VS	Main supply voltage for power half bridges.
6	OUT 3	Power half-bridge 3
7	OUT 1	Power half-bridge 1
8	GND	Ground
9	OUT 2	Power half-bridge 2
10	N.U.	Not used. This pin should either be left open or terminated to ground.
11	EN1	Enable input for Half-bridges 1/2 with internal pull-down
12	EN2	Enable input for Half-bridge 3 with internal pull-down
13	EF	Error Flag
14	VDD	Logic supply voltage
EDP	-	Exposed Die Pad; For cooling and EMC purposes only - not usable as electrical ground. Electrical ground must be provided by pins 8. ¹⁾

1) The exposed die pad at the bottom of the package allows better heat dissipation from the device via the PCB. The exposed pad (EP) must be either left open or connected to GND. It is recommended to connect EP to GND for best EMC and thermal performance.

Pin Configuration

Note: Not used (N.U.) pins and unused outputs are recommended to be left unconnected (open) on the application board. If N.U. pins or unused output pins are routed to an external connector which leaves the PCB, then these outputs should have provision for a zero ohm jumper (depopulated if unused) or ESD protection. In other words, they should be treated like used pins.

Block Diagram

2 Block Diagram

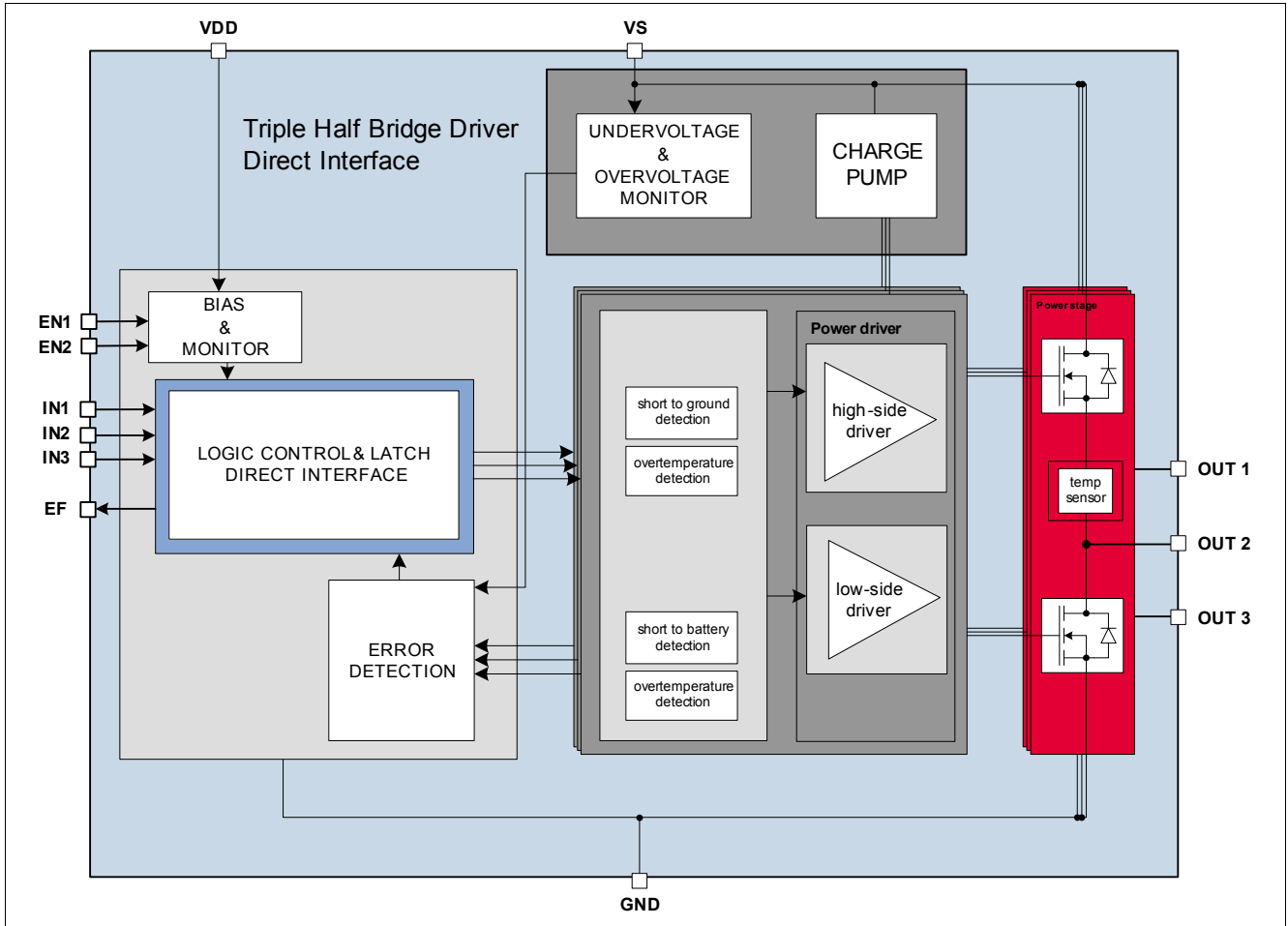


Figure 2 Block Diagram TLE94003EP (Direct Interface)

Block Diagram

2.1 Voltage and current definition

Figure 3 shows terms used in this datasheet, with associated convention for positive values.

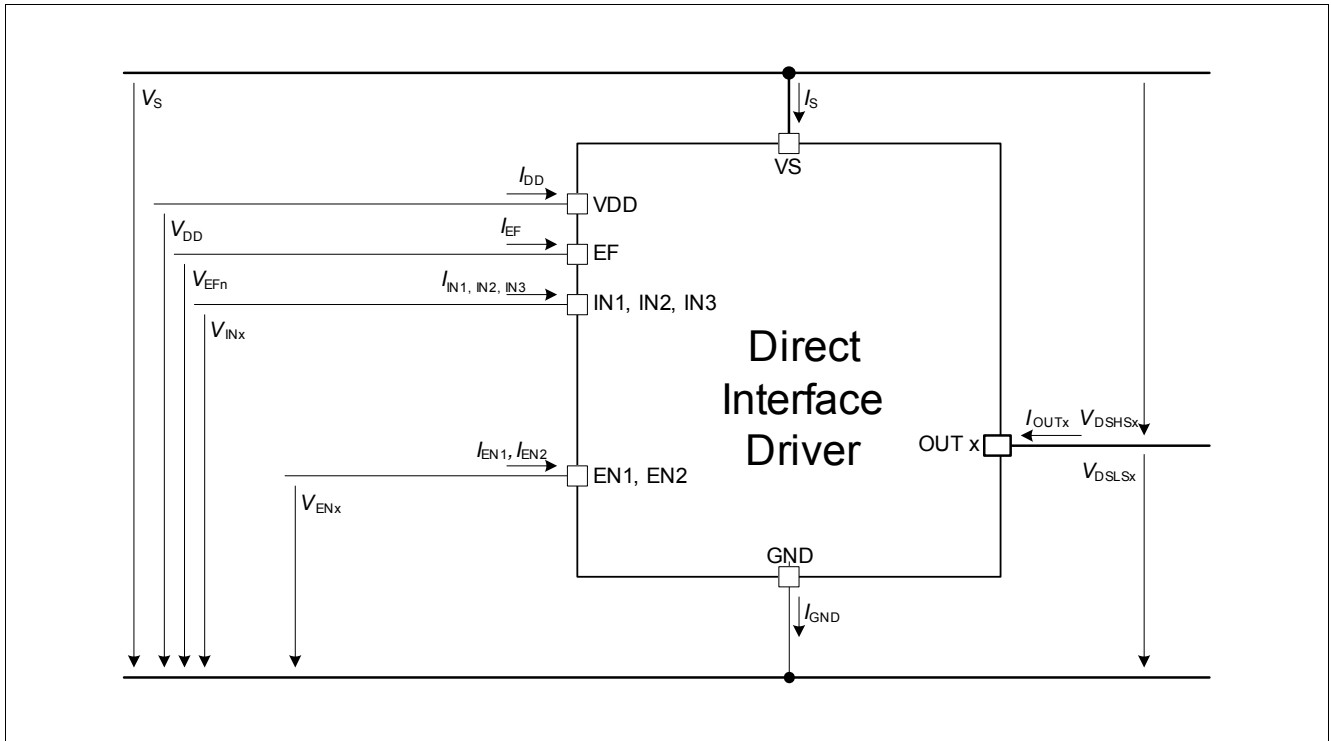


Figure 3 Voltage and Current Definition

General Product Characteristics

3 General Product Characteristics

3.1 Absolute Maximum Ratings

Table 2 Absolute Maximum Ratings¹⁾ $T_j = -40^\circ\text{C}$ to $+150^\circ\text{C}$

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Voltages							
Supply voltage	V_S	-0.3	–	40	V		P_4.1.1
Supply Voltage Slew Rate	$ dV_S/dt $	–	–	10	V/ μs	V_S increasing and decreasing ¹⁾	P_4.2.2
Power half-bridge output voltage	V_{OUT}	-0.3	–	40	V	$0\text{ V} < V_{\text{OUT}} < V_S$ ²⁾	P_4.1.2
Logic supply voltage	V_{DD}	-0.3	–	5.5	V	$0\text{ V} < V_S < 40\text{ V}$	P_4.1.3
Logic input voltages (EN1, EN2, IN1, IN2, IN3)	$V_{\text{ENn}}, V_{\text{INn}}$	-0.3	–	VDD	V	$0\text{ V} < V_S < 40\text{ V}$ $0\text{ V} < V_{\text{DD}} < 5.5\text{ V}$	P_4.1.16
Logic output voltage (EF)	V_{EF}	-0.3	–	VDD	V	$0\text{ V} < V_S < 40\text{ V}$ $0\text{ V} < V_{\text{DD}} < 5.5\text{ V}$	P_4.1.17
Currents							
Continuous Supply Current for V_S	I_S	0	–	1.5	A	–	P_4.1.20
Current per GND pin	I_{GND}	0	–	2.0	A	–	P_4.1.14
Output Currents	I_{OUT}	-2.0	–	2.0	A	–	P_4.1.15
Temperatures							
Junction temperature	T_j	-40	–	150	$^\circ\text{C}$	–	P_4.1.8
Storage temperature	T_{stg}	-50	–	150	$^\circ\text{C}$	–	P_4.1.9
ESD Susceptibility							
ESD susceptibility OUTn and VS pins versus GND. All other pins grounded.	V_{ESD}	-4	–	4	kV	JEDEC HBM ¹⁾³⁾	P_4.1.10
ESD susceptibility all pins	V_{ESD}	-2	–	2	kV	JEDEC HBM ¹⁾³⁾	P_4.1.11
ESD susceptibility all pins	V_{ESD}	-500	–	500	V	CDM ¹⁾⁴⁾	P_4.1.12
ESD susceptibility corner pins	V_{ESD}	-750	–	750	V	CDM ¹⁾⁴⁾	P_4.1.13

1) Not subject to production test, specified by design

2) Also applicable to not used (N.U.) pins

3) ESD susceptibility, "JEDEC HBM" according to ANSI/ ESDA/ JEDEC JS001 (1.5 k Ω , 100pF)

4) ESD susceptibility, Charged Device Model "CDM" according JEDEC JESD22-C101

Notes

1. Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

General Product Characteristics

- 2. Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as “outside” normal operating range. Protection functions are not designed for continuous repetitive operation.*

General Product Characteristics
3.2 Functional Range
Table 3 Functional Range

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Supply voltage range for normal operation	$V_{S(nor)}$	5.5	–	20	V	–	P_4.2.1
Logic supply voltage range for normal operation	V_{DD}	3.0	–	5.5	V	–	P_4.2.3
Logic input voltages (EN1, EN2, IN1, IN2, IN3)	V_{INn}, V_{ENn}	-0.3	–	5.5	V	–	P_4.2.6
Junction temperature	T_j	-40	–	150	°C		P_4.2.5

Note: Within the normal functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

General Product Characteristics

3.3 Thermal Resistance

Table 4 Thermal Resistance TLE94003EP

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Junction to Case, $T_A = -40^\circ\text{C}$	R_{thjC_cold}	–	16	–	K/W	1)	
Junction to Case, $T_A = 85^\circ\text{C}$	R_{thjC_hot}	–	19	–	K/W	1)	
Junction to ambient, $T_A = -40^\circ\text{C}$ (1s0p, minimal footprint)	$R_{thjA_cold_min}$	–	136	–	K/W	1) 2)	
Junction to ambient, $T_A = 85^\circ\text{C}$ (1s0p, minimal footprint)	$R_{thjA_hot_min}$	–	148	–	K/W	1) 2)	
Junction to ambient, $T_A = -40^\circ\text{C}$ (1s0p, 300mm ² Cu)	$R_{thjA_cold_300}$	–	79	–	K/W	1) 3)	
Junction to ambient, $T_A = 85^\circ\text{C}$ (1s0p, 300mm ² Cu)	$R_{thjA_hot_300}$	–	95	–	K/W	1) 3)	
Junction to ambient, $T_A = -40^\circ\text{C}$ (1s0p, 600mm ² Cu)	$R_{thjA_cold_600}$	–	77	–	K/W	1) 4)	
Junction to ambient, $T_A = 85^\circ\text{C}$ (1s0p, 600mm ² Cu)	$R_{thjA_hot_600}$	–	94	–	K/W	1) 4)	
Junction to ambient, $T_A = -40^\circ\text{C}$ (2s2p)	$R_{thjA_cold_2s2p}$	–	63	–	K/W	1) 5)	
Junction to ambient, $T_A = 85^\circ\text{C}$ (2s2p)	$R_{thjA_hot_2s2p}$	–	82	–	K/W	1) 5)	

1) Not subject to production test, specified by design.

2) Specified R_{thjA} value is according to JEDEC JESD51-2, -3 at natural convection on FR4 1s0p board; The product (chip + package) was simulated on a 76.2 x 114.3 x 1.5mm board with minimal footprint copper area and 35 μm thickness. $T_a = -40^\circ\text{C}$, each channel dissipates 0.2W. $T_a = 85^\circ\text{C}$, each channel dissipates 0.135W.

3) Specified R_{thjA} value is according to JEDEC JESD51-2, -3 at natural convection on FR4 1s0p board; The product (chip + package) was simulated on a 76.2 x 114.3 x 1.5mm board with additional cooling of 300mm² copper area and 35 μm thickness. $T_a = -40^\circ\text{C}$, each channel dissipates 0.2W. $T_a = 85^\circ\text{C}$, each channel dissipates 0.135W.

4) Specified R_{thjA} value is according to JEDEC JESD51-2, -3 at natural convection on FR4 1s0p board; The product (chip + package) was simulated on a 76.2 x 114.3 x 1.5mm board with additional cooling of 600mm² copper area and 35 μm thickness. $T_a = -40^\circ\text{C}$, each channel dissipates 0.2W. $T_a = 85^\circ\text{C}$, each channel dissipates 0.135W.

5) Specified R_{thjA} value is according to JEDEC JESD51-2, -3 at natural convection on FR4 2s2p board; The product (chip + package) was simulated on a 76.2 x 114.3 x 1.5mm board with two inner copper layers (4 x 35 μm Cu). $T_a = -40^\circ\text{C}$, each channel dissipates 0.2W. $T_a = 85^\circ\text{C}$, each channel dissipates 0.135W.

General Product Characteristics

3.4 Electrical Characteristics

Table 5 Electrical Characteristics, $V_S=5.5\text{ V to }20\text{ V}$, $V_{DD} = 3.0\text{ V to }5.5\text{ V}$, $T_j = -40^\circ\text{C to }+150^\circ\text{C}$, EN1= HIGH and EN2= HIGH, $I_{OUTn} = 0\text{ A}$; Typical values refer to $V_{DD} = 5.0\text{ V}$, $V_S = 13.5\text{ V}$ and $T_j = 25^\circ\text{C}$ unless otherwise specified; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Current Consumption, EN1 = EN2 = GND							
Supply Quiescent current	I_{SQ}	–	0.1	2	μA	$-40^\circ\text{C} \leq T_j \leq 85^\circ\text{C}$	P_4.4.1
Logic supply quiescent current	I_{DD_Q}	–	0.1	1	μA	$-40^\circ\text{C} \leq T_j \leq 85^\circ\text{C}$	P_4.4.2
Total quiescent current	$I_{SQ} + I_{DD_Q}$	–	0.6	3	μA	$-40^\circ\text{C} \leq T_j \leq 85^\circ\text{C}$	P_4.4.3
Current Consumption, EN=HIGH							
Supply current	I_{S_HSON}	–	1.5	3	mA	All high-sides ON ¹⁾²⁾	P_4.4.101
Logic supply current	I_{DD}	–	0.6	2.5	mA		P_4.4.5
Over- and Undervoltage Lockout							
Undervoltage Switch ON voltage threshold	$V_{UV\ ON}$	4.4	4.90	5.3	V	V_S increasing	P_4.4.8
Undervoltage Switch OFF voltage threshold	$V_{UV\ OFF}$	4	4.50	4.9	V	V_S decreasing	P_4.4.9
Undervoltage Switch ON/OFF hysteresis	$V_{UV\ HY}$	–	0.40	–	V	$V_{UV\ ON} - V_{UV\ OFF}$ ²⁾	P_4.4.10
Oversvoltage Switch OFF voltage threshold	$V_{OV\ OFF}$	21	23	25	V	V_S increasing	P_4.4.11
Oversvoltage Switch ON voltage threshold	$V_{OV\ ON}$	20	22	24	V	V_S decreasing	P_4.4.12
Oversvoltage Switch ON/OFF hysteresis	$V_{OV\ HY}$	–	1	–	V	$V_{OV\ OFF} - V_{OV\ ON}$ ²⁾	P_4.4.13
V_{DD} Power-On-Reset	$V_{DD\ POR}$	2.40	2.63	2.90	V	V_{DD} increasing	P_4.4.14
V_{DD} Power-Off-Reset	$V_{DD\ PoffR}$	2.35	2.57	2.85	V	V_{DD} decreasing	P_4.4.15
V_{DD} Power ON/OFF hysteresis	$V_{DD\ POR\ HY}$	–	0.06	–	V	$V_{DD\ POR} - V_{DD\ PoffR}$ ²⁾	P_4.4.98
Static Drain-source ON-Resistance (High-Side or Low-Side)							
High-Side or Low-Side R_{DSON} (all outputs)	$R_{DSON_HB_25C}$	–	825	1200	m Ω	$I_{OUT} = \pm 0.5\text{ A}$; $T_j = 25^\circ\text{C}$	P_4.4.16
High-Side or Low-Side R_{DSON} (all outputs)	$R_{DSON_HB_150C}$	–	1350	1800	m Ω	$I_{OUT} = \pm 0.5\text{ A}$; $T_j = 150^\circ\text{C}$	P_4.4.17
Output Protection and Diagnosis of high-side (HS) channels of half-bridge output							
HS Overcurrent Shutdown Threshold	I_{SD_HS}	-1.5	-1.2	-0.9	A	See Figure 7	P_4.4.20
Difference between shutdown and limit current	$I_{LIM_HS} - I_{SD_HS}$	-1.2	-0.6	0	A	²⁾ $ I_{LIM_HS} \geq I_{SD_HS} $ See Figure 7	P_4.4.21

General Product Characteristics

Table 5 Electrical Characteristics, $V_S = 5.5\text{ V to }20\text{ V}$, $V_{DD} = 3.0\text{ V to }5.5\text{ V}$, $T_j = -40^\circ\text{C to }+150^\circ\text{C}$, EN1= HIGH and EN2= HIGH, $I_{OUTn} = 0\text{ A}$; Typical values refer to $V_{DD} = 5.0\text{ V}$, $V_S = 13.5\text{ V}$ and $T_j = 25^\circ\text{C}$ unless otherwise specified; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified) (cont'd)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Overcurrent Shutdown filter time	t_{dSD_HS}	15	19	23	μs	²⁾	P_4.4.22

Output Protection and Diagnosis of low-side (LS) channels of half-bridge output

LS Overcurrent Shutdown Threshold	I_{SD_LS}	0.9	1.2	1.5	A	See Figure 8	P_4.4.27
Difference between shutdown and limit current	$I_{LIM_LS} - I_{SD_LS}$	0	0.6	1.2	A	²⁾ $I_{LIM_LS} \geq I_{SD_LS}$ Figure 8	P_4.4.28
Overcurrent Shutdown filter time	t_{dSD_LS}	15	19	23	μs	²⁾	P_4.4.29

Outputs OUT(1...n) leakage current

HS leakage current in off state	I_{QLHn_NOR}	-2	-0.5	-	μA	$V_{OUTn} = 0\text{V}$; OUT1/2: EN1=GND, EN2=High; OUT3: EN1=High, EN2=GN D	P_4.4.32
HS leakage current in off state	I_{QLHn_SLE}	-2	-0.5	-	μA	$V_{OUTn} = 0\text{V}$; EN1 = EN2 =GND	P_4.4.33
LS Leakage current in off state	I_{QLLn_NOR}	-	0.5	2	μA	$V_{OUTn} = V_S$; OUT1/2: EN1=GND, EN2=High; OUT3: EN1=High, EN2=GN D	P_4.4.34
LS Leakage current in off state	I_{QLLn_SLE}	-	0.5	2	μA	$V_{OUTn} = V_S$; EN1 = EN2 =GND	P_4.4.35

Output Switching Times. See **Figure 9 and **Figure 10**.**

Slew rate of high-side and low-side outputs	d_{VOUT}/dt	0.1	0.45	0.75	$\text{V}/\mu\text{s}$	Resistive load = 100Ω ; $V_S = 13.5\text{V}$ ³⁾	P_4.4.36
Output delay time high side driver on	t_{dONH}	5	20	35	μs	Resistive load = 100Ω to GND	P_4.4.37
Output delay time high side driver off	t_{dOFFH}	15	45	75	μs	Resistive load = 100Ω to GND	P_4.4.38
Output delay time low side driver on	t_{dONL}	5	20	35	μs	Resistive load = 100Ω to VS	P_4.4.39
Output delay time low side driver off	t_{dOFFL}	15	45	75	μs	Resistive load = 100Ω to VS	P_4.4.40
Cross current protection time, high to low	t_{DHL}	100	130	160	μs	Resistive load = 100Ω ²⁾	P_4.4.41
Cross current protection time, low to high	t_{DLH}	100	130	160	μs	Resistive load = 100Ω ²⁾	P_4.4.42

General Product Characteristics

Table 5 Electrical Characteristics, $V_S = 5.5\text{ V to }20\text{ V}$, $V_{DD} = 3.0\text{ V to }5.5\text{ V}$, $T_j = -40^\circ\text{C to }+150^\circ\text{C}$, EN1= HIGH and EN2= HIGH, $I_{OUTn} = 0\text{ A}$; Typical values refer to $V_{DD} = 5.0\text{ V}$, $V_S = 13.5\text{ V}$ and $T_j = 25^\circ\text{C}$ unless otherwise specified; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified) (cont'd)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Input Interface: Logic Inputs EN1, EN2							
Set up time after sleep mode	t_{SET_DI}	–	–	150	μs	²⁾ See Figure 5	P_4.4.49
High-input voltage	V_{ENH}	0.7 * V_{DD}	–	V_{DD}	V	–	P_4.4.43
Low-input voltage	V_{ENL}	0	–	0.3 * V_{DD}	V	–	P_4.4.44
Hysteresis of input voltage	V_{ENHY}	–	500	–	mV	²⁾	P_4.4.45
Pull down resistor	R_{PD_EN}	20	40	70	k Ω	$V_{EN} = 0.2 \times V_{DD}$	P_4.4.46
EF reset time	t_{EF_RESET}	250	–	–	ns	²⁾ Set ENx to Low for t_{EF_RESET} to reset EF	P_4.4.121
Input Interface: Logic Inputs IN1, IN2, IN3							
High input voltage threshold	V_{INnH}	0.7 * V_{DD}	–	V_{DD}	V	–	P_4.4.90
Low input voltage threshold	V_{INnL}	0	–	0.3 * V_{DD}	V	–	P_4.4.91
Hysteresis of input voltage	V_{INnHY}	–	500	–	mV	²⁾	P_4.4.92
Pull-down resistor	R_{PD}	20	40	70	k Ω	–	P_4.4.94
Output Interface: Logic Output EF							
High output voltage level	V_{EFH}	$V_{DD} - 0.4$	$V_{DD} - 0.2$	V_{DD}	V	$I_{EFH} = -1.6\text{ mA}$	P_4.4.88
Low output voltage level	V_{EFL}	0	0.2	0.4	V	$I_{EFL} = 1.6\text{ mA}$	P_4.4.95
Leakage current	I_{EFLK}	-1	–	1	μA	$0\text{ V} < V_{EF} < 5.5\text{ V}$	P_4.4.96
Thermal Shutdown							
Thermal shutdown junction temperature	T_{jSD}	160	175	190	$^\circ\text{C}$	See Figure 11 ²⁾	P_4.4.81
Thermal comparator hysteresis	T_{jHYS}	–	4	–	$^\circ\text{C}$	²⁾	P_4.4.82

1) I_{S_HSON} does not include the load current

2) Not subject to production test, specified by design

3) Measured for 20% - 80% of V_S .

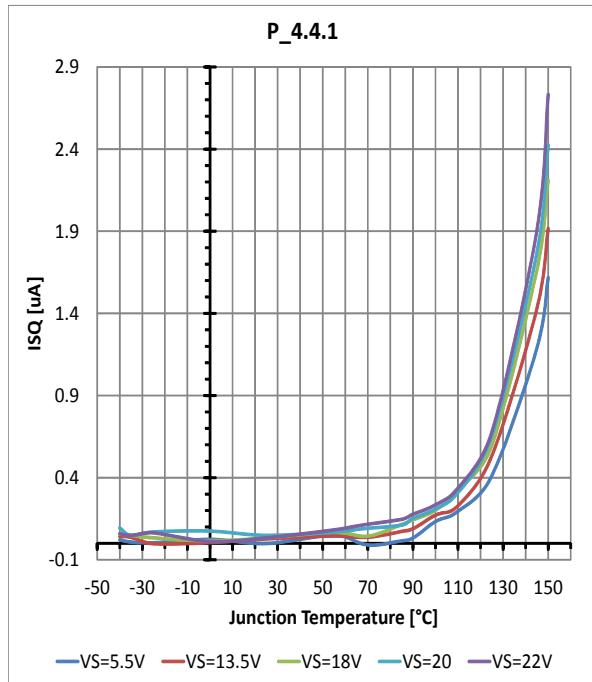
Characterization results

4 Characterization results

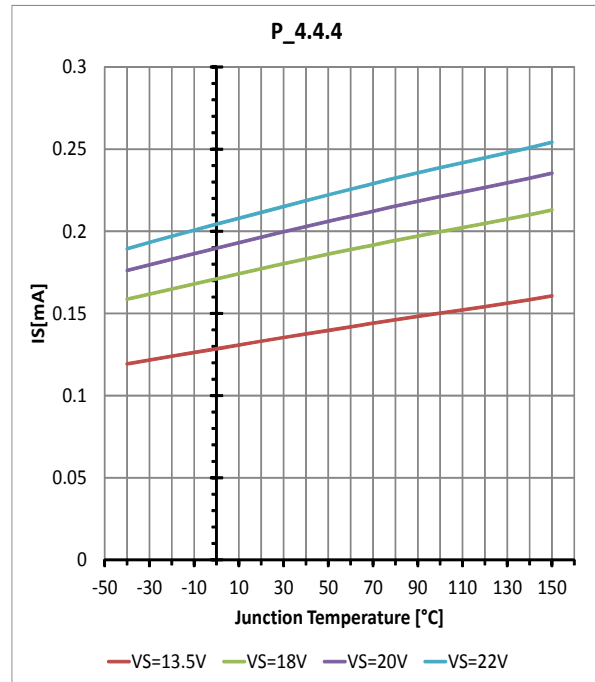
Performed on 5 devices, over operating temperature and nominal/extended supply range.

Typical performance characteristics

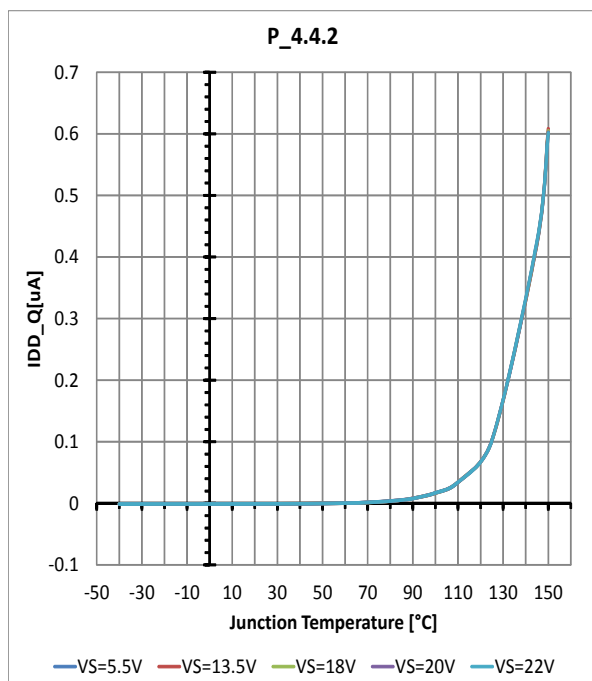
Supply quiescent current



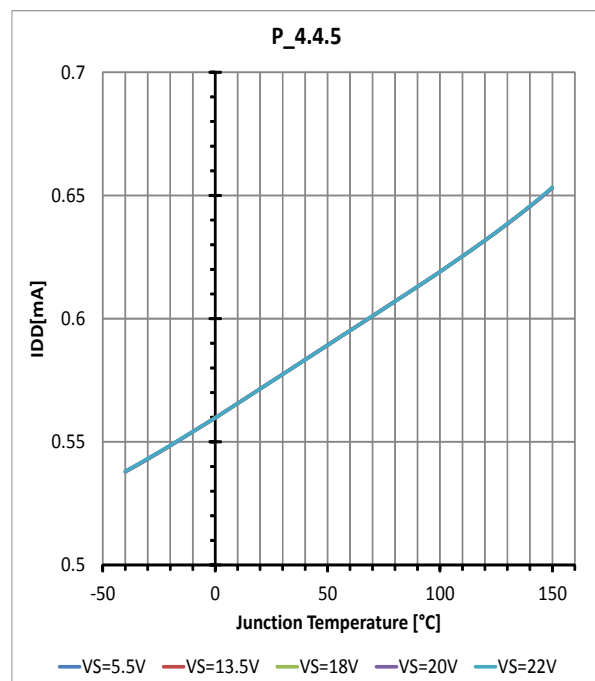
Supply current



Logic supply quiescent current

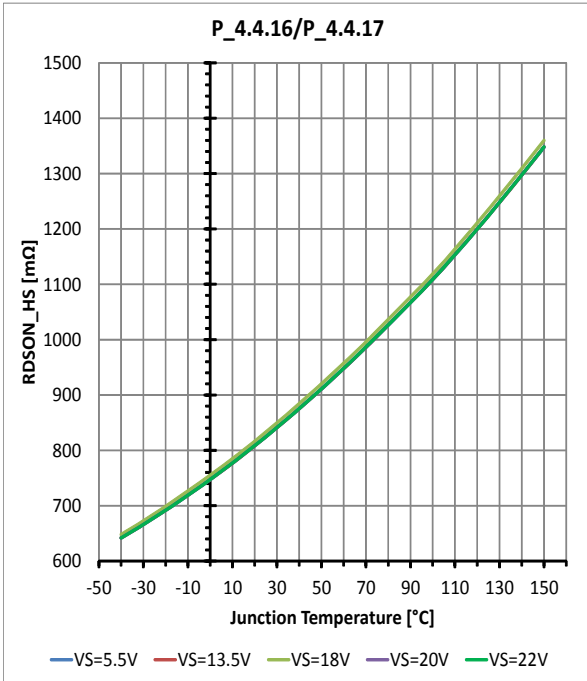


Logic supply current

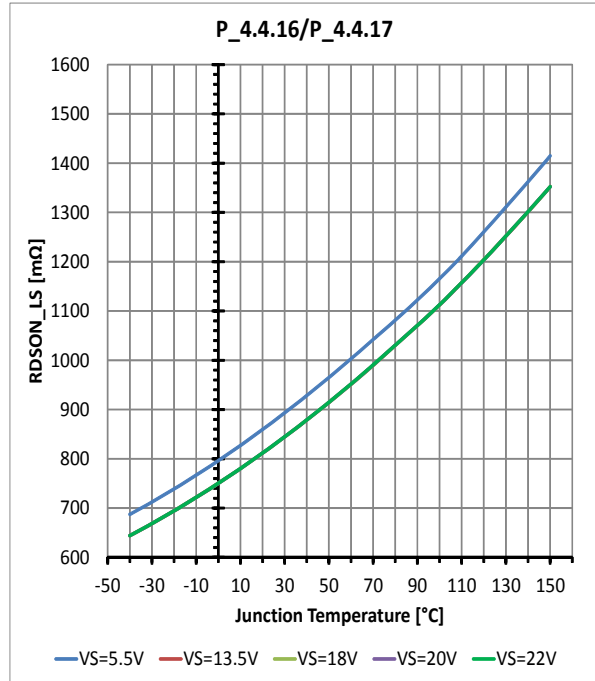


Characterization results

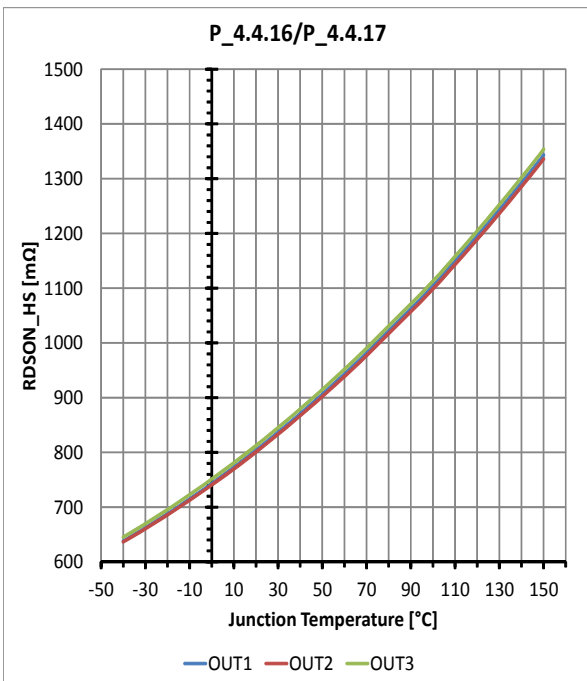
HS static Drain-source ON-resistance



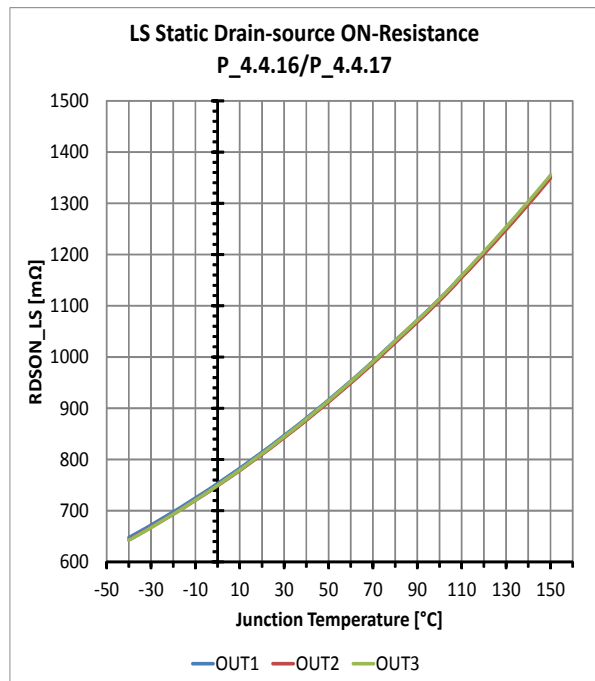
LS static Drain-source ON-resistance



HS static drain-source ON-resistance
VS = 13.5V and VDD = 5V

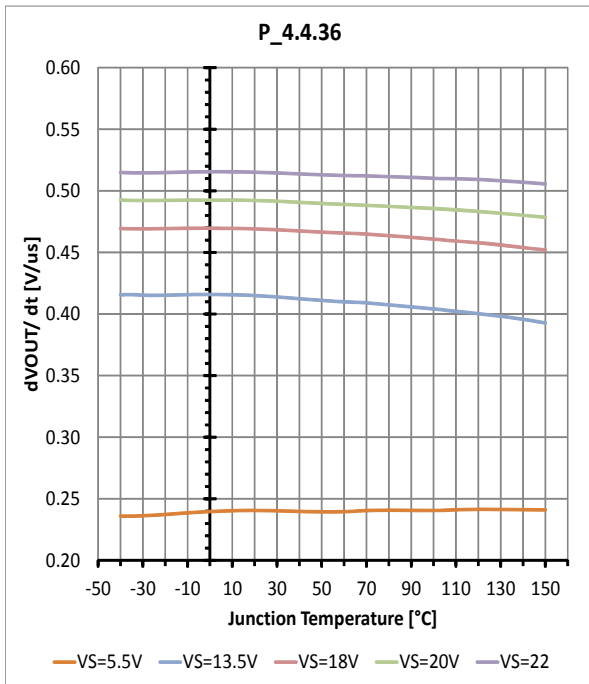


LS static drain-source ON-resistance
VS = 13.5V and VDD = 5V

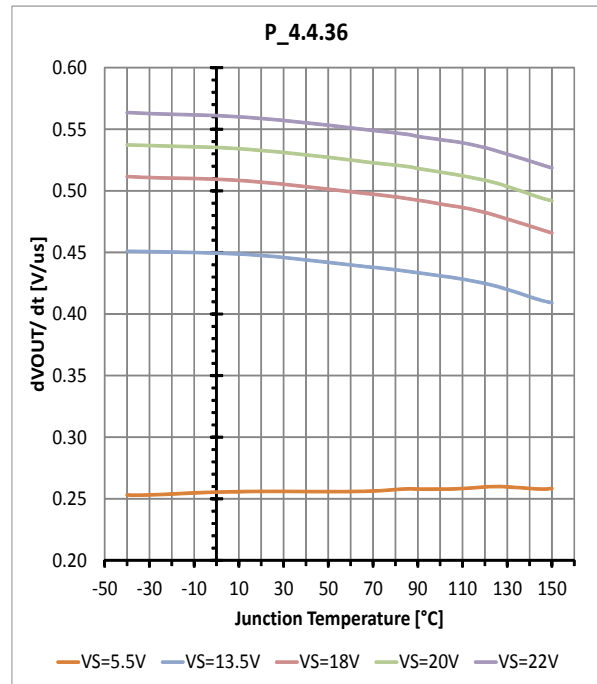


Characterization results

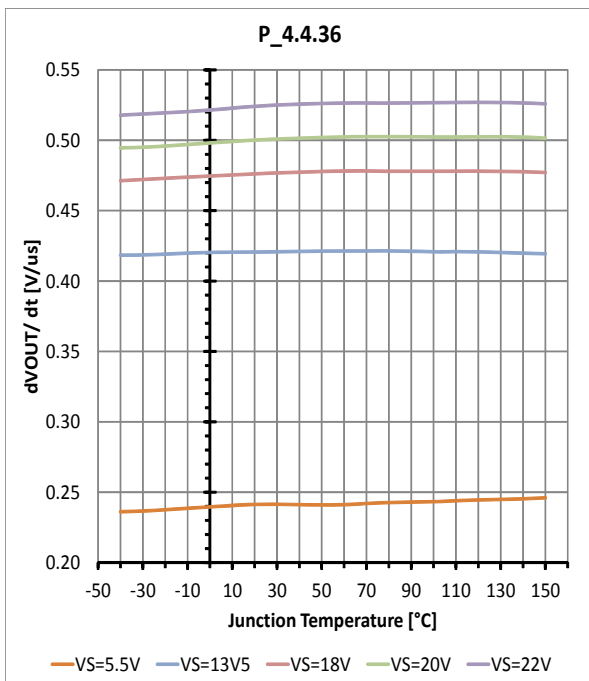
Slew rate ON of high-side outputs



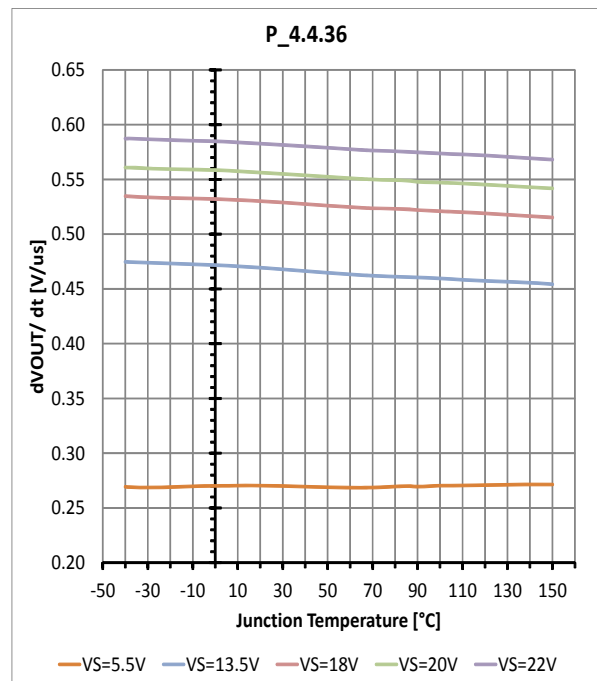
Slew rate ON of low-side outputs



Slew rate OFF of high-side outputs

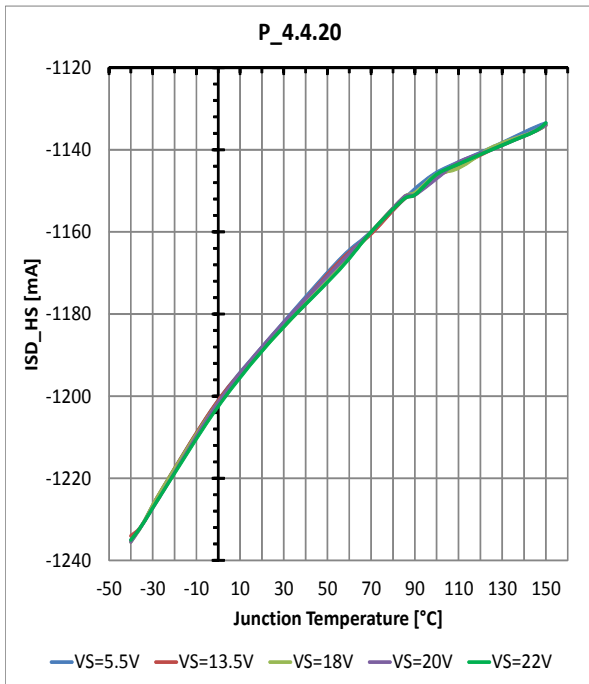


Slew rate OFF of low-side outputs

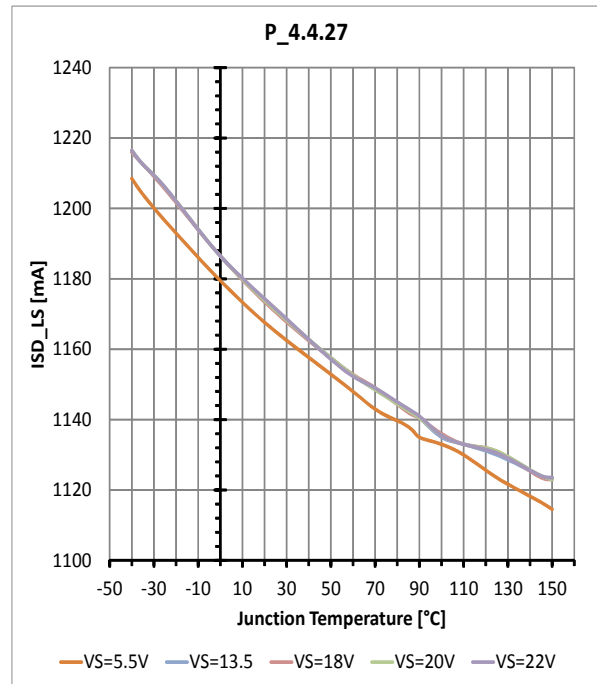


Characterization results

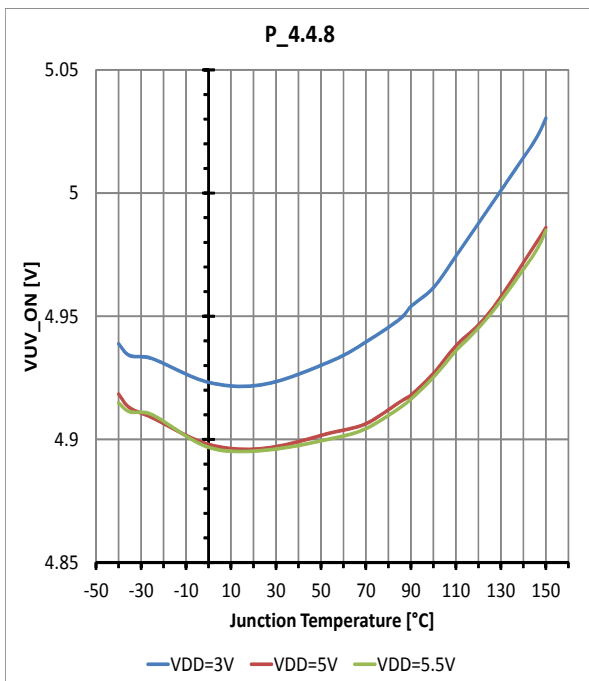
HS overcurrent shutdown threshold



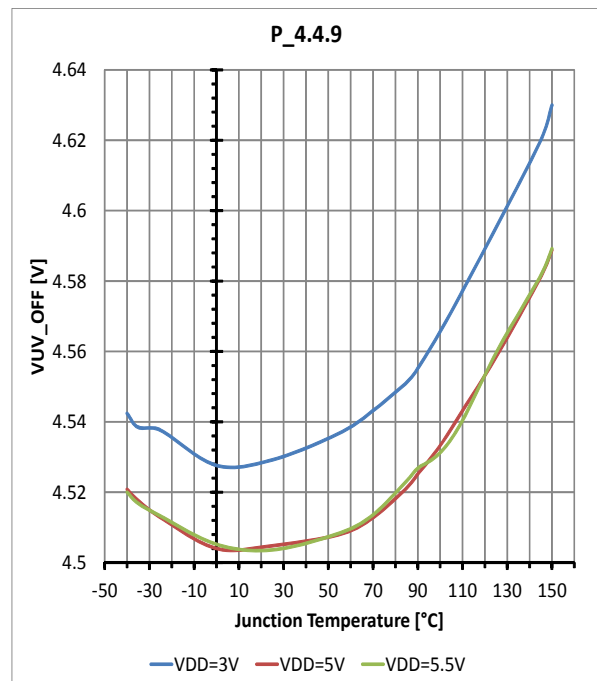
LS overcurrent shutdown threshold



Undervoltage switch ON voltage threshold

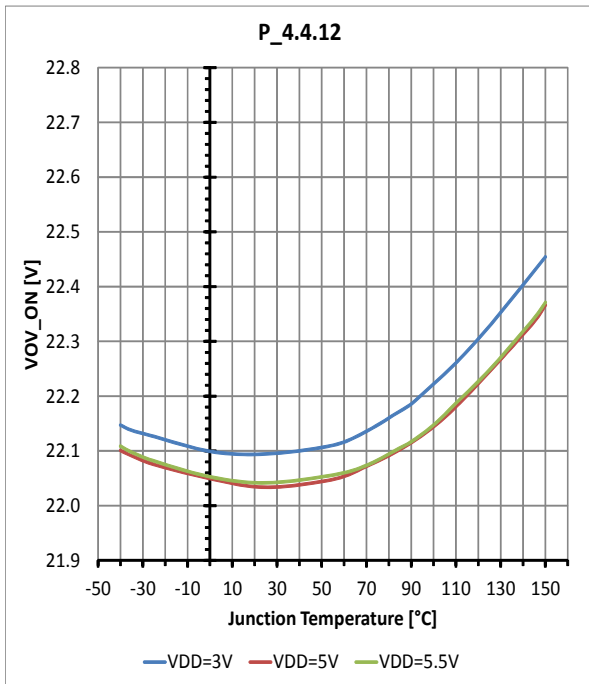


Undervoltage switch OFF voltage threshold

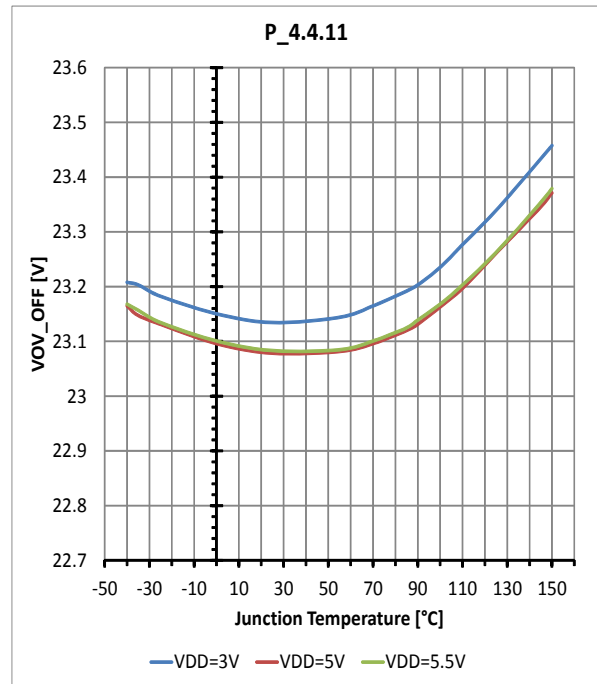


Characterization results

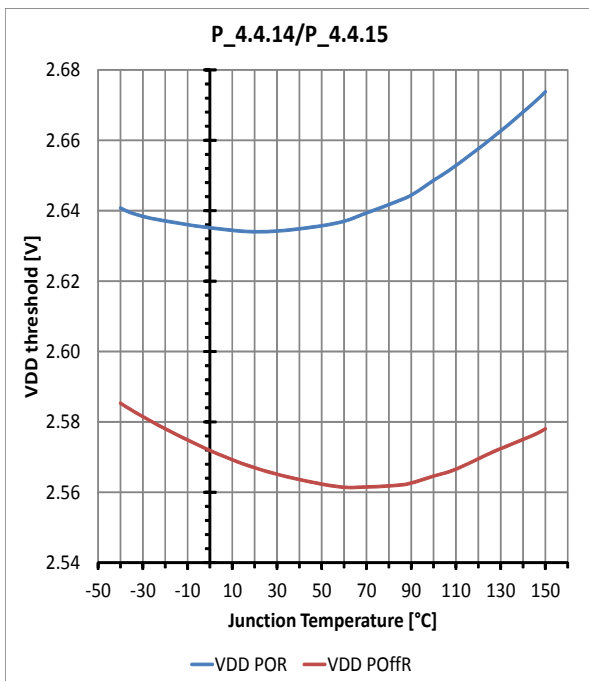
Overvoltage switch ON voltage threshold



Overvoltage switch OFF voltage threshold



VDD Power-on-reset and VDD Power-off-reset



General Description

5 General Description

5.1 Power Supply

The TLE94003EP has two power supply inputs, V_S and V_{DD} . The half bridge outputs are supplied by V_S , which is connected to the 12V automotive supply rail. V_{DD} is used to supply the I/O buffers and internal voltage regulator of the device.

V_S and V_{DD} supplies are separated so that information stored in the logic block remains intact in the event of voltage drop outs or disturbances on V_S . The system can therefore continue to operate once V_S has recovered, without having to resend commands to the device.

A rising edge on V_{DD} crossing $V_{DD\text{POR}}$ triggers an internal Power-On Reset (POR) to initialize the IC at power-on. All data stored internally is deleted, and the outputs are switched off (high impedance).

An electrolytic and 100nF ceramic capacitors are recommended to be placed as close as possible to the V_S supply pin of the device for improved EMC performance in the high and low frequency band. The electrolytic capacitor must be dimensioned to prevent the V_S voltage from exceeding the absolute maximum rating. In addition, decoupling capacitors are recommended on the V_{DD} supply pin.

5.2 Operation modes

5.2.1 Normal mode

The TLE94003EP enters normal mode by setting EN1 or EN2 to High. In normal mode, the charge pump is active and all output transistors can be activated or deactivated according to [Chapter 6.1](#).

5.2.2 Sleep mode

The TLE94003EP enters sleep mode by setting the EN1 and EN2 pins to Low. The EN1 and EN2 inputs have an internal pull-down resistor.

In sleep mode, all output transistors are turned off and the logic content is reset. The current consumption is reduced to $I_{SQ} + I_{DD_Q}$.

5.3 Reset Behaviour

The following reset triggers have been implemented in the TLE94003EP:

V_{DD} Undervoltage Reset:

The digital block will be deactivated, the logic contents cleared and the output stages are switched off if V_{DD} is below the undervoltage threshold, $V_{DD\text{POffR}}$. The digital block is initialized once V_{DD} voltage levels is above the undervoltage threshold, $V_{DD\text{POR}}$.

Reset on EN1/2 pins:

If the EN1/2 pins are pulled Low, the logic content is reset and the device enters sleep mode.

5.4 Reverse Polarity Protection

The TLE94003EP requires an external reverse polarity protection. During reverse polarity, the free-wheeling diodes across the half bridge output will begin to conduct, causing an undesired current flow (I_{RB}) from ground potential to battery and excessive power dissipation across the diodes. As such, a reverse polarity protection diode is recommended (see [Figure 4](#)).

General Description

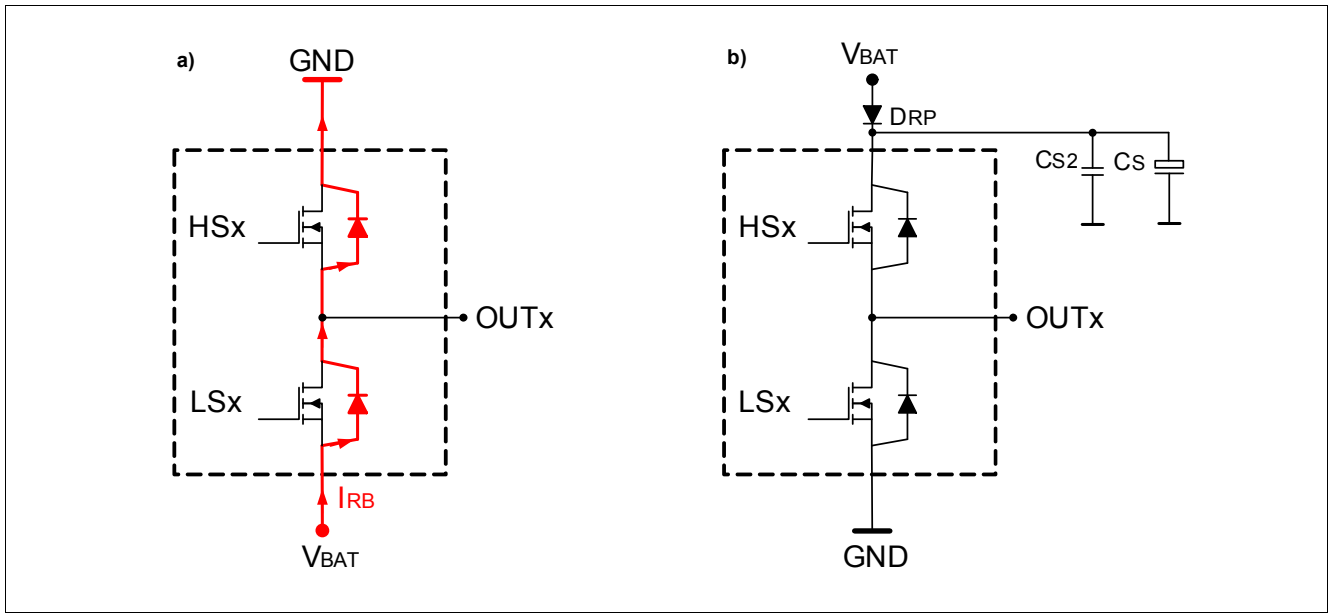


Figure 4 Reverse Polarity Protection

Half-Bridge Outputs

6 Half-Bridge Outputs

The half-bridge outputs of the TLE94003EP are intended to drive motor loads. They consist of a total of three DMOS half-bridges, which can be driven either continuously or in PWM via INx pins. The output stages integrated circuits protect the outputs against overcurrent and overtemperature.

6.1 Output Stages

EN1 and EN2 inputs control the state of the device according to [Table 6](#).

- When EN1 = 0 and EN2 = 0, the device enters sleep mode with low power consumption and all outputs are OFF (high impedance).
- When EN1=1, HB1 and HB2 are enabled
- When EN2=1, HB3 is enabled

Table 6 Device states

EN1	EN2	HB1/2	HB 3	Device state
0	0	OFF	OFF	Sleep mode, all outputs are OFF
0	1	OFF	Enabled	Device is in normal mode
1	0	Enabled	OFF	Device is in normal mode
1	1	Enabled	Enabled	Device is in normal mode

Note: After the transition from sleep mode to normal mode, the outputs are OFF for a duration t_{SET_DI} . See [Figure 5](#)

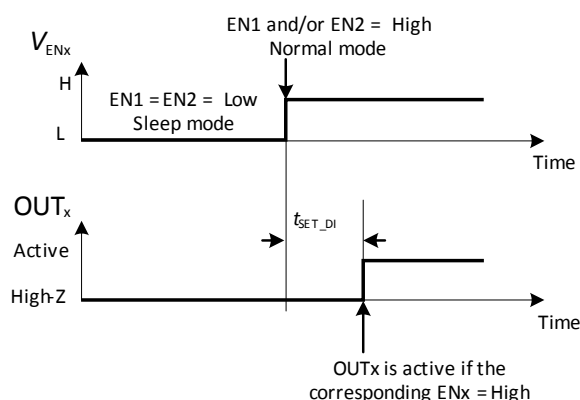


Figure 5 Output setup time after a transition from standby to normal mode

The control inputs consist of CMOS-compatible schmitt-triggers with hysteresis. There are altogether three control inputs, i.e. IN1, IN2 and IN3 with internal pull-down resistors.

If EN1 = 0, HB1 and HB2 are OFF. If EN1 = 1, HB1 and HB2 are controlled according to [Table 7](#)

Table 7 Functional Truth Table for HB1 and HB2

EN1	IN1	IN2	HB1	HB2	Mode
0	X	X	OFF	OFF	HB1 and HB2 are OFF
1	0	0	L	L	Brake Low

Half-Bridge Outputs

Table 7 Functional Truth Table for HB1 and HB2

EN1	IN1	IN2	HB1	HB2	Mode
1	0	1	L	H	Motor counter-clockwise
1	1	0	H	L	Motor clockwise
1	1	1	H	H	Brake High

If EN2 = 0, HB3 is high impedance. If EN2 = 1, the states of HB3 is controlled according to [Table 8](#)

Table 8 Functional Truth table for HB3

EN2	IN3	HB3
0	X	OFF
1	0	L
1	1	H

If two motors are connected in cascaded configuration (see [Figure 6](#)), the motors and the half-bridges behave according to [Table 9](#).

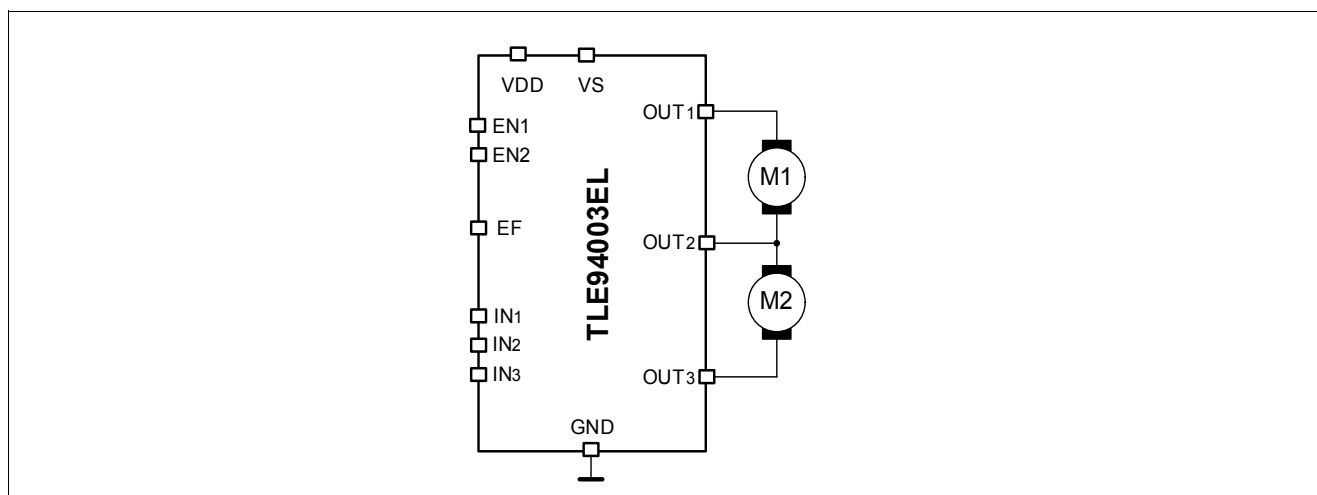


Figure 6 TLE94003EP with two motors in cascaded configuration

Table 9 Functional Truth Table for HB1, HB2 and HB3 controlling two cascaded motors

EN1	EN2	IN1	IN2	IN3	HB1	HB2	HB3	Motor1	Motor 2
0	0	X	X	X	OFF	OFF	OFF	OFF	OFF
1	0	0	0	X	L	L	OFF	Brake Low	OFF
1	0	0	1	X	L	H	OFF	Counter-clockwise	OFF
1	0	1	0	X	H	L	OFF	Clockwise	OFF
1	0	1	1	X	H	H	OFF	Brake High	OFF
1	1	0	0	0	L	L	L	Brake Low	Brake Low
1	1	0	0	1	L	L	H	Brake Low	Counter-clockwise
1	1	0	1	0	L	H	L	Counter-clockwise	Clockwise
1	1	0	1	1	L	H	H	Counter-clockwise	Brake High
1	1	1	0	0	H	L	L	Clockwise	Brake Low

Half-Bridge Outputs**Table 9 Functional Truth Table for HB1, HB2 and HB3 controlling two cascaded motors**

EN1	EN2	IN1	IN2	IN3	HB1	HB2	HB3	Motor1	Motor 2
1	1	1	0	1	H	L	H	Clockwise	Counter-clockwise
1	1	1	1	0	H	H	L	Brake High	Clockwise
1	1	1	1	1	H	H	H	Brake High	Brake High

Half-Bridge Outputs

6.2 Diagnosis Monitoring

The EF pin (push-pull output) reports the following error conditions:

- Overcurrent (OC)
- Overtemperature (OT)
- VS overvoltage and VS undervoltage

EF reports an overcurrent event on HB1/2 only if EN1 = 1. Likewise, EF reports an overcurrent on HB3 only if EN2 = 1.

After an overcurrent event is detected on HB1/2, EF is latched to 1, until EN1 = 0. Likewise, after an overcurrent event detected on HB3, EF is latched to 1 until EN2 = 0.

EF reports overtemperature or VS overvoltage/undervoltage events if the device is in normal mode (EN1 = 1 or EN2 = 1). The error flag is latched to 1 for these fault conditions until EN1 = 0 and EN2 = 0

Table 10 Error reporting by EF pin

EN1	EN2	Error reported by EF pin
0	0	Not applicable, the device is in sleep mode
1	0	OC on HB1/2, OT, VS under/overvoltage
0	1	OC on HB3, OT, VS under/overvoltage
1	1	OC on HB1/2, OC on HB3, OT, VS under/overvoltage

The table below depicts the EF behaviour:

Table 11 Error flag behaviour and reset conditions

Fault condition	EF	Reset conditions
No fault	0	–
Overcurrent on HB1 or HB2	1 (latched)	Set EN1 pin to 0 for TEF_RESET
Overcurrent on HB3	1 (latched)	Set EN2 pin to 0 for TEF_RESET
VS overvoltage	1 (latched)	$V_S < V_{OVON}$, EN1 = 0 and EN2 = 0 for TEF_RESET
VS undervoltage	1 (latched)	$V_S > V_{UVON}$, EN1 = 0 and EN2 = 0 for TEF_RESET
Overtemperature	1 (latched)	EN1 = 0 and EN2 = 0 for TEF_RESET

6.3 Protection

This device has embedded protective functions which are designed to prevent the destruction of the device under fault conditions described in this section. Fault conditions are treated as “outside” normal operating range. Protection functions are not designed for continuous repetitive operation.

6.3.1 Short Circuit of Output to Supply or Ground

The high-side switches are protected against short circuits to ground whereas the low-side switches are protected against short circuits to supply.

The high-side and low-side switches will enter into an over-current condition if the current within the switch exceeds the overcurrent shutdown detection threshold, I_{SD} . Upon detection of the I_{SD} threshold, an